

Notice of References Cited

Application/Control No.

10/776,063

Applicant(s)/Patent Under
Reexamination
BENCO ET AL.

Examiner

Arlen Soderquist

Art Unit

1743

Page 1 of 2

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U	Sabbatini, N. et al, Inorganica Chimica Acta 1996, 252, 19-24. NO MONTH			
	V	Chen, Y. et al, Synthetic Communications 1999, 29, 705-711. NO MONTH			
	W	Kim, J. S. et al, Journal of Organic Chemistry 2000, 65, 2386-2392. NO MONTH			
	X	Marchand, A. P. et al, Tetrahedron 2000, 56, 3121-3126. NO MONTH			

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited

Application/Control No.

10/776,063

Applicant(s)/Patent Under
Reexamination
BENCO ET AL.

Examiner

Arlen Soderquist

Art Unit

1743

Page 2 of 2

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Chen, Y. et al, Tetrahedron Letters 2000, 41, 4815-4818. (NO MONTH)
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.